N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^c	Q _g (Typ.)			
20	0.7at V _{GS} = 4.5 V	0.6	0.79 nC			
20	0.85at V _{GS} = 2.5 V	0.56	0.79110			

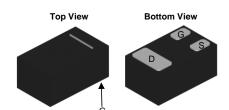
FEATURES

- **DT-Trench Power MOSFET**
- 100 % R_g Tested
 Compliant to RoHS Directive 2002/95/EC
- Gate-Source ESD Protected

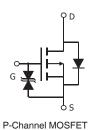


APPLICATIONS

· Load Switch



DFN 1006



Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 12	
	T _C = 25 °C		0.6	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		0.45	
Continuous Diam Curient (1) = 130 °C)	T _A = 25 °C	I _D	0.28 ^{a, b}	
	T _A = 70 °C		0.12 ^{a, b}	A
Pulsed Drain Current	I _{DM}	2.2		
Continuous Source-Drain Diode Current	T _C = 25 °C	la la	0.6	
Continuous Source-Diam Diode Current	T _A = 25 °C	I _S	0.29	
	T _C = 25 °C		0.68	
Maximum Davier Dissination	T _C = 70 °C	P _D	0.43	w
Maximum Power Dissipation	T _A = 25 °C	'D	0.22 ^{a, b}	VV
	T _A = 70 °C		0.14 ^{a, b}	
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature)		260		

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on $T_C = 25$ °C.



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THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R_{thJA}	250	510	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	225	680]		

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 360 °C/W.

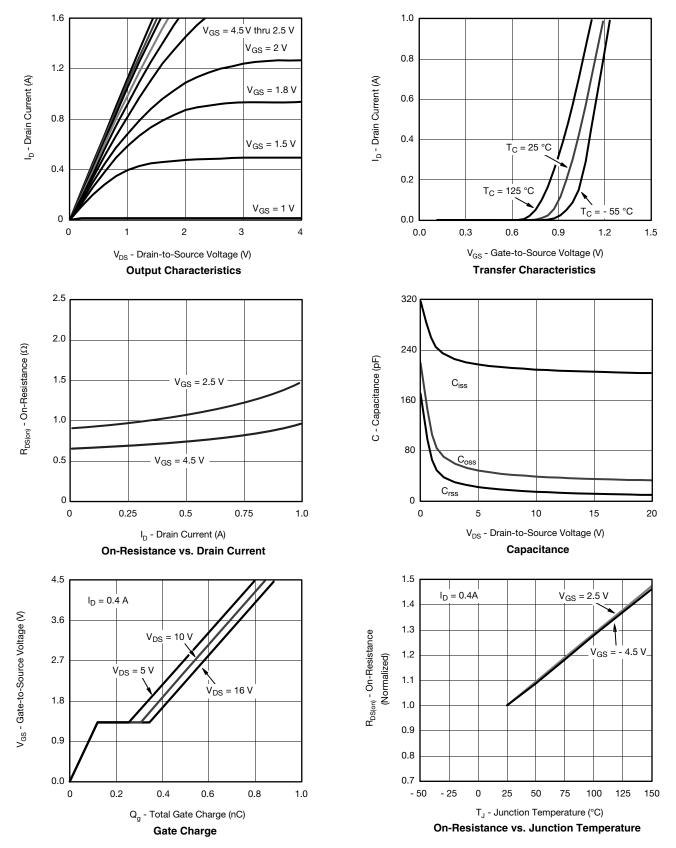
Parameter	Symbol Test Conditions			Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		14		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		2.4		1110/	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.4		1.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	1	V _{DS} = 20 V, V _{GS} = 0 V			1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	0.6			Α	
Drain-Source On-State Resistance ^a	В	$V_{GS} = 4.5 \text{ V}, I_D = 0.4 \text{ A}$	0.7 0.95		0.95		
Dialii-Source Oil-State Resistance	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 0.2 A		0.85	1.5	Ω	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 5 \text{ V}, I_{D} = 0.4 \text{ A}$		1.5		S	
Dynamic ^b							
Input Capacitance	C _{iss}			226		pF	
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		53			
Reverse Transfer Capacitance	C _{rss}			16			
Total Gate Charge	Qg			0.85		nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 0.4 \text{ A}$		0.19			
Gate-Drain Charge	Q_gd			0.25			
Gate Resistance	R_{g}	f = 1 MHz		43		Ω	
Turn-On Delay Time	t _{d(on)}			8			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 9.2 \Omega$		7		ns	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 0.4 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		16			
Fall Time	t _f			6			
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			0.6	^	
Pulse Diode Forward Current ^a	I _{SM}				2.2	- A	
Body Diode Voltage	V _{SD}	I _F = 0.4 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			18		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 0 4 A 41/44 400 A/v. T 05 00		7		nC	
Reverse Recovery Fall Time	t _a	$I_F = 0.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		8			
Reverse Recovery Rise Time	t _b			12		ns	

Notes

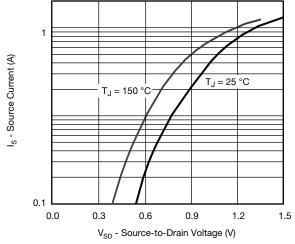
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

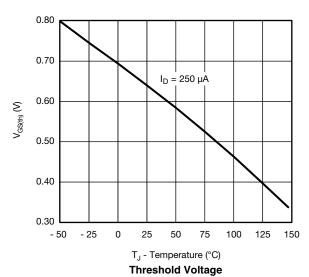








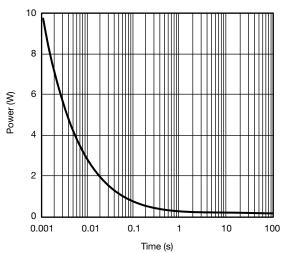
Source-Drain Diode Forward Voltage



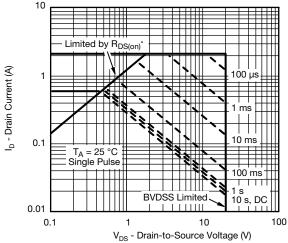
2.0 $I_D = 0.4A$ $I_J = 125 \, ^{\circ}C$ $T_J = 25 \, ^{\circ}C$ $T_J = 25 \, ^{\circ}C$

V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



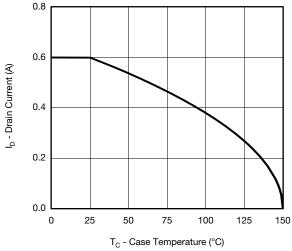
Single Pulse Power, Junction-to-Ambient



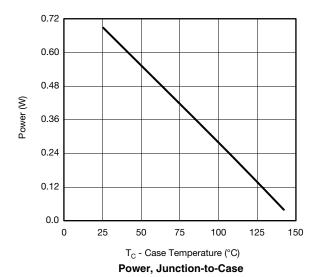
 v_{DS} - Drain-to-Source voltage (v) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

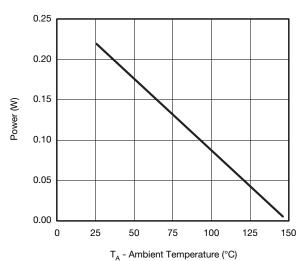
Safe Operating Area, Junction-to-Ambient





Current Derating*

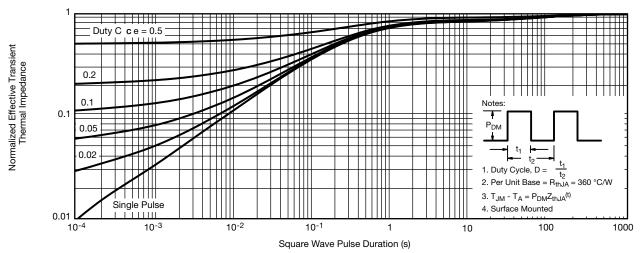




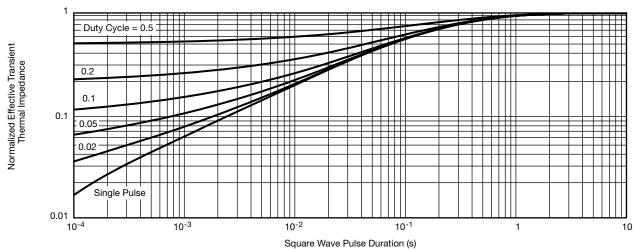
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

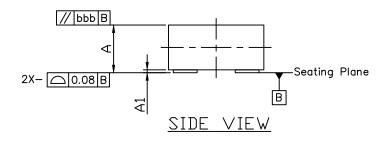


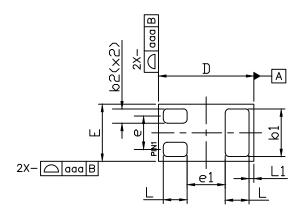
Normalized Thermal Transient Impedance, Junction-to-Foot



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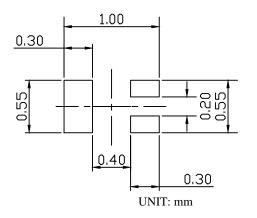
DFN1.0x0.6_3L_EP1_S PACKAGE OUTLINE





BOTTOM VIEW

RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
STRIBULS	MIN	NDM	MAX	MIN	NDM	MAX	
Α	0.47	0.52	0.55	0.019	0.020	0.022	
A1	0.00	0.03	0.05	0.000	0.001	0.002	
b1	0.45	0.50	0.55	0.018	0.020	0.022	
b2	0.10	0.15	0.20	0.004	0.006	0.008	
D	0.95	1.00	1.05	0.037	0.039	0.041	
E	0.55	0.60	0.65	0.022	0.024	0.026	
e		0.35			0.014		
e1		0.40			0.016		
L	0.20	0.25	0.30	0.008	0.010	0.012	
L1		0.05			0.002		
aaa	0.15			0.006			
bbb	0.05			0.002			

NOTE

- 1. ALL DIMENSION ARE IN MILLIMETERS.ANGLES ARE IN DEGREES.
- 2. COPLANARITY APPLIES TO THE EXPOSED HEAT SINK SLUG AS WELL AS THE TERMINALS.





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